

TOSHIBA

2SK1381

TOSHIBA FIELD EFFECT TRANSISTOR SILICON N CHANNEL MOS TYPE (L²-π-MOSIII)

2SK1381

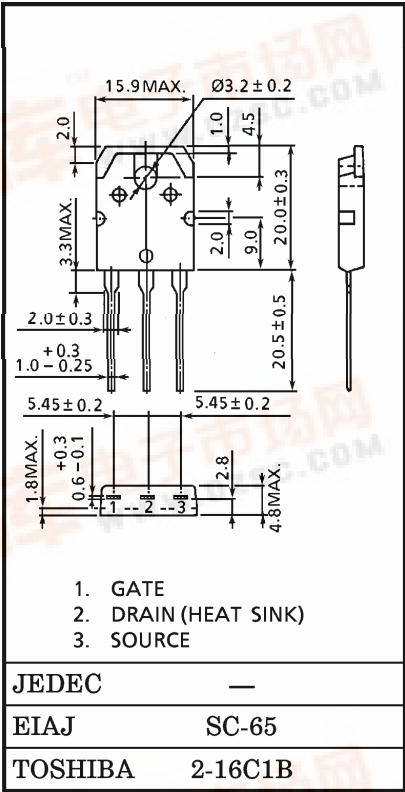
HIGH SPEED SWITCHING APPLICATIONS
RELAY DRIVE, MOTOR DRIVE AND DC-DC CONVERTER APPLICATIONS

INDUSTRIAL APPLICATIONS
Unit in mm

- 4V Gate Drive
- Low Drain-Source ON Resistance : $R_{DS(ON)} = 25m\Omega$ (Typ.)
- High Forward Transfer Admittance : $|Y_{fs}| = 33S$ (Typ.)
- Low Leakage Current : $I_{DSS} = 100\mu A$ (Max.) ($V_{DS} = 100V$)
- Enhancement-Mode : $V_{th} = 0.8 \sim 2.0V$ ($V_{DS} = 10V$, $I_D = 1mA$)

MAXIMUM RATINGS ($T_a = 25^\circ C$)

CHARACTERISTIC		SYMBOL	RATING	UNIT
Drain-Source Voltage		V_{DSS}	100	V
Drain-Gate Voltage ($R_{GS} = 20k\Omega$)		V_{DGR}	100	V
Gate-Source Voltage		V_{GSS}	± 20	V
Drain Current	DC	I_D	50	A
	Pulse	I_{DP}	200	
Drain Power Dissipation ($T_c = 25^\circ C$)		P_D	150	W
Channel Temperature		T_{ch}	150	$^\circ C$
Storage Temperature Range		T_{stg}	$-55 \sim 150$	$^\circ C$



Weight : 4.6g

THERMAL CHARACTERISTICS

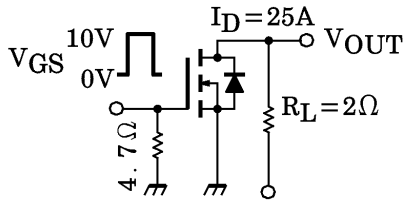
CHARACTERISTIC	SYMBOL	MAX.	UNIT
Thermal Resistance, Channel to Case	$R_{th(ch-c)}$	0.833	$^\circ C / W$
Thermal Resistance, Channel to Ambient	$R_{th(ch-a)}$	50	$^\circ C / W$

This transistor is an electrostatic sensitive device.
Please handle with caution.

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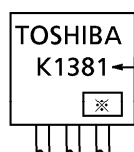
ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC		SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Gate Leakage Current		I_{GSS}	$V_{GS} = \pm 20V, V_{DS} = 0V$	—	—	± 10	nA
Drain Cut-off Current		I_{DSS}	$V_{DS} = 100V, V_{GS} = 0V$	—	—	100	μA
Drain-Source Breakdown Voltage		$V_{(BR) DSS}$	$I_D = 10mA, V_{GS} = 0V$	100	—	—	V
Gate Threshold Voltage		V_{th}	$V_{DS} = 10V, I_D = 1mA$	0.8	—	2.0	V
Drain-Source ON Resistance		$R_{DS(ON)}$	$V_{GS} = 4V, I_D = 25A$	—	31	46	m Ω
			$V_{GS} = 10V, I_D = 25A$	—	25	32	
Forward Transfer Admittance		$ Y_{fs} $	$V_{DS} = 10V, I_D = 25A$	20	33	—	S
Input Capacitance		C_{iss}	$V_{DS} = 10V, V_{GS} = 0V, f = 1MHz$	—	3700	—	pF
Reverse Transfer Capacitance		C_{rss}		—	580	—	
Output Capacitance		C_{oss}		—	1500	—	
Switching Time	Rise Time	t_r	 $I_D = 25A$ V_{OUT} $R_L = 2\Omega$ $V_{DD} \doteq 50V$ $V_{IN} : t_r, t_f < 5ns,$ $Duty \leq 1\%, t_w = 10\mu s$	—	16	—	ns
	Turn-on Time	t_{on}		—	46	—	
	Fall Time	t_f		—	60	—	
	Turn-off Time	t_{off}		—	185	—	
Total Gate Charge (Gate-Source Plus Gate-Drain)		Q_g	$V_{DD} \doteq 80V, V_{GS} = 10V, I_D = 50A$	—	88	—	nC
Gate-Source Charge		Q_{gs}		—	62	—	
Gate-Drain ("Miller") Charge		Q_{gd}		—	26	—	

SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Continuous Drain Reverse Current	I_{DR}	—	—	—	50	A
Pulse Drain Reverse Current	I_{DRP}	—	—	—	200	A
Diode Forward Voltage	V_{DSF}	$I_{DR} = 50A, V_{GS} = 0V$	—	—	−1.6	V
Reverse Recovery Time	t_{rr}	$I_{DR} = 50A, V_{GS} = 0V$	—	280	—	ns
Reverse Recovered Charge	Q_{rr}	$dI_{DR} / dt = 50A / \mu s$	—	0.56	—	μC

MARKING



※ Lot Number



Month (Starting from Alphabet A)

Year (Last Number of the Christian Era)

